

**Search Notes**

Application/Control No.

10/522,559

Examiner

SANG KIM

Applicant(s)/Patent under  
Reexamination

DREFS ET AL.

Art Unit

3654

**SEARCHED**

Class	Subclass	Date	Examiner
242	541 541.4-.7 547	3/14/2007	SK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
John Nguyen: 242/541.5	3/14/2007	SK